# SILICON TRANSISTOR **2SB1453**

# PNP SILICON EPITAXIAL POWER TRANSISTOR FOR HIGH-SPEED SWITCHING

The 2SB1453 is a power transistor that can directly drive from the IC output. This transistor is ideal for motor drivers and solenoid drivers in such as OA and FA equipment.

In addition, a small resin-molded insulation type package contributes to high-density mounting and reduction of mounting cost.

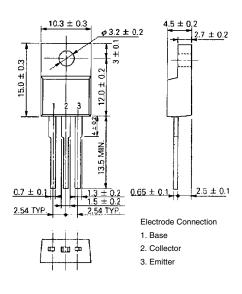
## **FEATURES**

NEC

- · High DC current amplifier ratio  $h_{FE} \ge 100 (V_{CE} = -5 V, I_{C} = -0.5 A)$
- · Mold package that does not require an insulating board or insulation bushing

| ABSOLUTE MAXIMUM RATINGS (Ta = 25°C) |                |             |      |  |  |  |  |  |
|--------------------------------------|----------------|-------------|------|--|--|--|--|--|
| Parameter                            | Symbol         | Ratings     | Unit |  |  |  |  |  |
| Collector to base voltage            | Vсво           | -60         | V    |  |  |  |  |  |
| Collector to emitter voltage         | VCEO           | -60         | V    |  |  |  |  |  |
| Emitter to base voltage              | Vebo           | -7.0        | V    |  |  |  |  |  |
| Collector current (DC)               | IC(DC)         | -3.0        | А    |  |  |  |  |  |
| Collector current (pulse)            | IC(pulse)*     | -6.0        | А    |  |  |  |  |  |
| Base current (DC)                    | IB(DC)         | -1.0        | А    |  |  |  |  |  |
| Total power dissipation              | P⊤ (Tc = 25°C) | 25          | W    |  |  |  |  |  |
| Total power dissipation              | P⊤ (Ta = 25°C) | 2.0         | W    |  |  |  |  |  |
| Junction temperature                 | Tj             | 150         | °C   |  |  |  |  |  |
| Storage temperature                  | Tstg           | –55 to +150 | °C   |  |  |  |  |  |

 $PW \le 10 \text{ ms}$ , duty cycle  $\le 50\%$ 



### PACKAGE DRAWING (UNIT: mm)

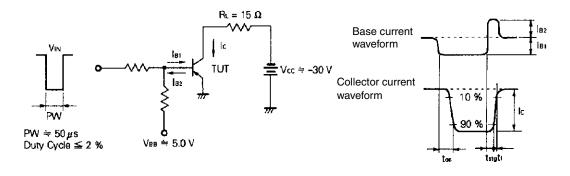
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# ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| Parameter                    | Symbol                  | Conditions  | MIN. | TYP. | MAX. | Unit |
|------------------------------|-------------------------|---|------|------|------|------|
| Collector cutoff current     | Ісво                    | $V_{CB} = -60 \text{ V}, I_E = 0$   |      |      | -10  | μA   |
| DC current gain              | hfe1**                  | $V_{CE} = -5.0 \text{ V}, \text{ Ic} = -0.5 \text{ A}$  | 100  |      | 400  | -    |
| DC current gain              | hfe2**                  | $V_{CE} = -5 V$ , $I_C = -3 A$  | 20   |      |      | -    |
| Collector saturation voltage | V <sub>CE(sat)</sub> ** | Ic = −3.0 A, I <sub>B</sub> = −300 mA   |      |      | -1.0 | V    |
| Base saturation voltage      | V <sub>BE(sat)</sub> ** | Ic = −3.0 A, I <sub>B</sub> = −300 mA   |      |      | -2.0 | V    |
| Gain bandwidth product       | f⊤                      | $V_{CE} = -5.0 \text{ V}, \text{ Ic} = -0.5 \text{ A}$  |      | 5    |      | MHz  |
| Collector capacitance        | Cob                     | $V_{CB} = -10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1.0 \text{ MHz}$  |      | 80   |      | pF   |
| Turn-on time                 | ton                     | $\label{eq:lc} \begin{array}{l} lc = -2.0 \mbox{ A},  l_{B1} = -l_{B2} = -200 \mbox{ mA}, \\ R_L = 15 \ \Omega,  Vcc \cong -30 \mbox{ V} \\ \mbox{ Refer to the test circuit.} \end{array}$ |      | 0.4  |      | μs   |
| Storage time                 | tstg                    |   |      | 1.7  |      | μs   |
| Fall time                    | tr                      |   |      | 0.5  |      | μs   |

\*\* Pulse test PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2%

## SWITCHING TIME (ton, tstg, tf) TEST CIRCUIT



United

100

–100 mA

-80 mA

60 mA 40 mA

-6

in =

-20 mA

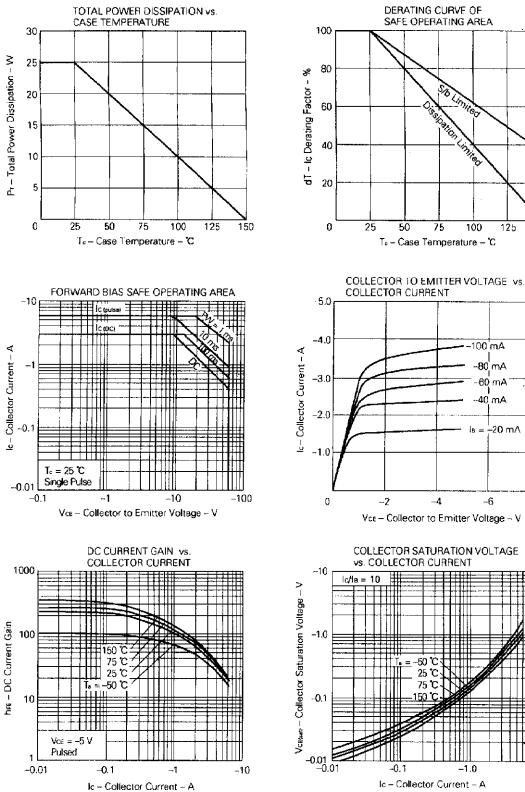
-8

-10

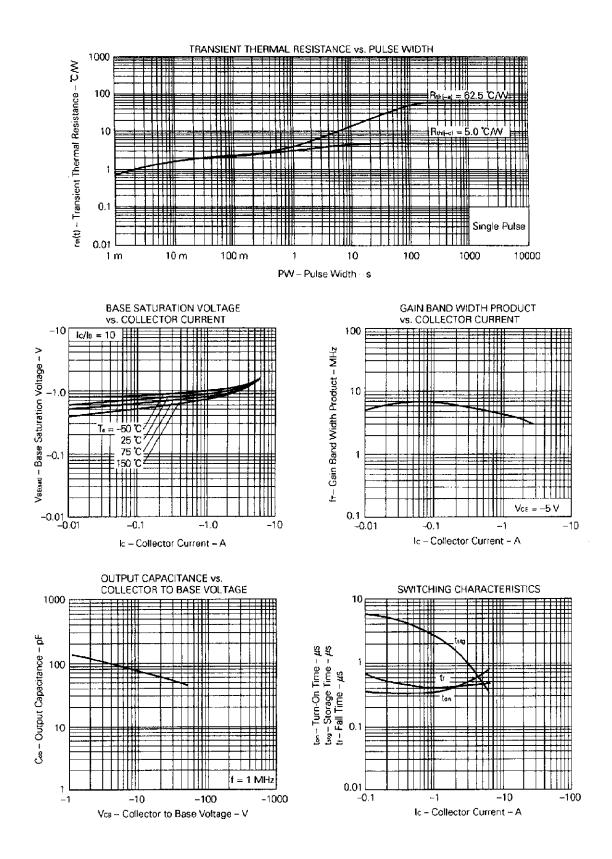
125

150





-1.0



[MEMO]

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